# Power MOSFET

## –20 V, –7.7 A, μCool <sup>™</sup> Single P–Channel, 2x2 mm, WDFN Package

## Features

- WDFN Package Provides Exposed Drain Pad for Excellent Thermal Conduction
- 2x2 mm Footprint Same as SC-88 Package
- Lowest R<sub>DS(on)</sub> Solution in 2x2 mm Package
- 1.5 V R<sub>DS(on)</sub> Rating for Operation at Low Voltage Logic Level Gate Drive
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- This is a Pb-Free Device

## Applications

- DC-DC Converters (Buck and Boost Circuits)
- Optimized for Battery and Load Management Applications in Portable Equipment such as, Cell Phones, PDA's, Media Players, etc.
- High Side Load Switch

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Paran	neter		Symbol	Value	Unit														
Drain-to-Source Voltag	ge		V <sub>DSS</sub>	-20	V														
Gate-to-Source Voltag	V <sub>GS</sub>	±8.0	V																
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-5.8	А														
Current (Note 1)	State	$T_A = 85^{\circ}C$		-4.4															
	t ≤ 5 s	$T_A = 25^{\circ}C$		-7.7															
Power Dissipation (Note 1)	Steady State T <sub>A</sub> = 25°C		PD	1.9	W														
	t≤5 s			3.3															
Continuous Drain		$T_A = 25^{\circ}C$	۱ <sub>D</sub>	-3.5	А														
Current (Note 2)	Steady															$T_A = 85^{\circ}C$		-2.5	
Power Dissipation (Note 2)	State	$T_A = 25^{\circ}C$	PD	0.7	W														
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	-23	А														
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C														
Source Current (Body Diode) (Note 2)			۱ <sub>S</sub>	-2.8	А														
Lead Temperature for S (1/8" from case for 10 s		urposes	ΤL	260	°C														

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

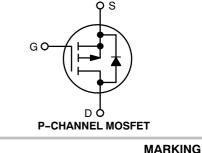
- 1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size, (30 mm<sup>2</sup>, 2 oz Cu).

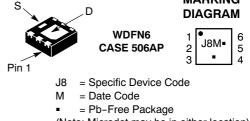


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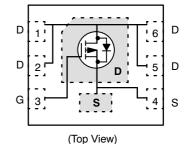
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	ID MAX (Note 1)
	40 mΩ @ -4.5 V	
-20 V	50 mΩ @ −2.5 V	-7.7 A
-20 V	75 mΩ @ -1.8 V	-1.1 A
	200 mΩ @ -1.5 V	





(Note: Microdot may be in either location)

#### **PIN CONNECTIONS**



#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLJS3113PT1G	WDFN6	3000/Tape & Reel
NTLJS3113PTAG	(Pb-Free)	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	65	
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	$R_{ hetaJA}$	38	°C/W
Junction-to-Ambient – Steady State Min Pad (Note 4)	$R_{\theta JA}$	180	

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm<sup>2</sup>, 2 oz Cu).

#### **MOSFET ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = -250 $\mu$ A		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = -250 \ \mu A$ , Ref to $25^{\circ}C$			-10.1		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -16 V, V_{GS} = 0 V$ $T_J = 25^{\circ}C$				-1.0	μΑ
		$v_{\rm DS} = -16  v,  v_{\rm GS} = 0  v$ $T_{\rm J} = 85^{\circ} {\rm C}$				-10	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ±8.0 V				±1.0	μΑ
ON CHARACTERISTICS (Note 5)	-				-		

**ON CHARACTERISTICS** (Note 5)

Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = -250 \ \mu A$	-0.45	-0.67	-1.0	V
Negative Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>			2.68		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5$ , $I_D = -3.0$ A		32	40	mΩ
		$V_{GS} = -2.5$ , $I_D = -3.0$ A		44	50	
		V <sub>GS</sub> = -1.8, I <sub>D</sub> = -2.0 A		67	75	
		V <sub>GS</sub> = -1.5, I <sub>D</sub> = -1.8 A		90	200	
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = -16 V, I <sub>D</sub> = -3.0 A		5.9		S

#### CHARGES, CAPACITANCES AND GATE RESISTANCE

Input Capacitance	C <sub>ISS</sub>			1329		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = -16 V	-	213		
Reverse Transfer Capacitance	C <sub>RSS</sub>			120		
Total Gate Charge	Q <sub>G(TOT)</sub>			13	15.7	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub> = -16 V, I <sub>D</sub> = -3.0 A		1.5		
Gate-to-Source Charge	Q <sub>GS</sub>	$I_{\rm D} = -3.0 \rm{A}$		2.2		
Gate-to-Drain Charge	Q <sub>GD</sub>			2.9		
Gate Resistance	R <sub>G</sub>			14.4		Ω

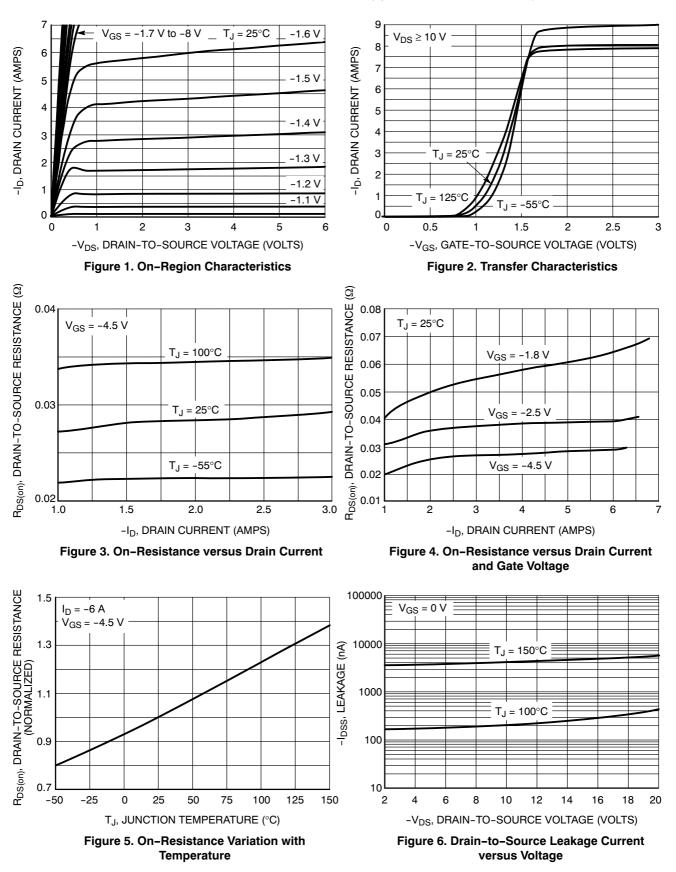
#### SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	t <sub>d(ON)</sub>		6.9	ns
Rise Time	t <sub>r</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$	17.5	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D$ = -3.0 A, $R_G$ = 3.0 $\Omega$	60	
Fall Time	t <sub>f</sub>		56.5	

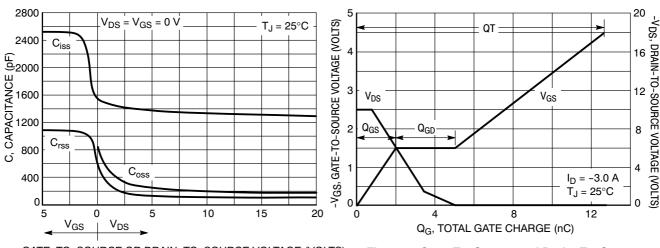
#### DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Recovery Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, IS = -1.0 A	T <sub>J</sub> = 25°C	-0.78	-1.2	V
		VGS = 0 V, 13 = -1.0 A	T <sub>J</sub> = 125°C	-0.67		v
Reverse Recovery Time	t <sub>RR</sub>			70.8	106	
Charge Time	ta	$V_{GS} = 0 V, d_{ISD}/d_t = 1$ $I_S = -1.0 A$	00 A/μs,	14.3		ns
Discharge Time	t <sub>b</sub>	I <sub>S</sub> = -1.0 A		56.4		
Reverse Recovery Time	Q <sub>RR</sub>			44		nC

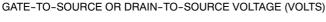
5. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2%. 6. Switching characteristics are independent of operating junction temperatures.



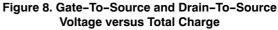
TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

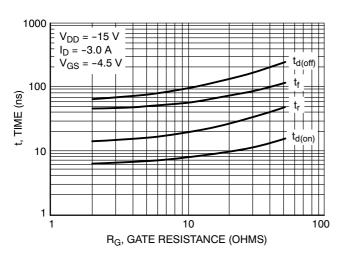


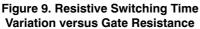
#### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)











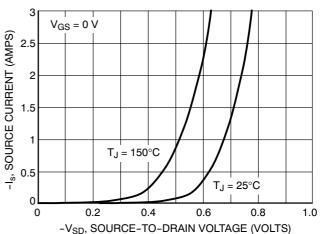
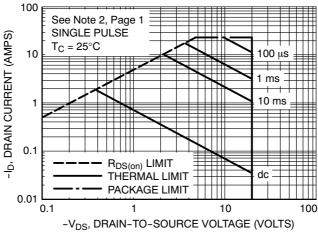
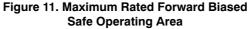
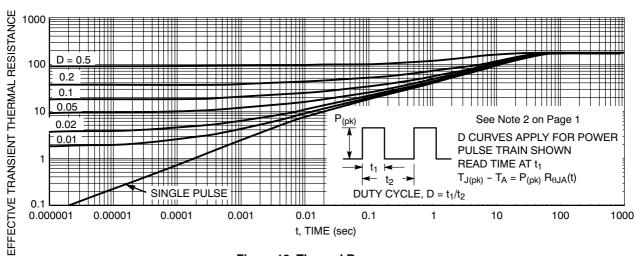


Figure 10. Diode Forward Voltage versus Current





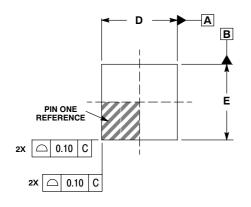


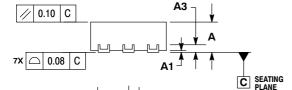
#### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

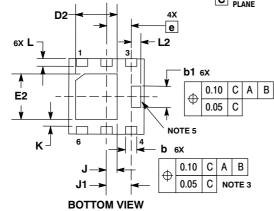
Figure 12. Thermal Response

#### PACKAGE DIMENSIONS

WDFN6 CASE 506AP-01 **ISSUE A** 





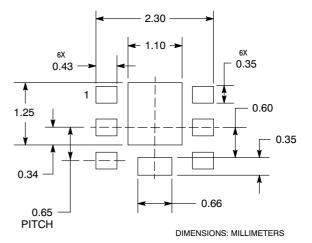


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND 3. IS MEASURED BETWEEN 0.15 AND 0.20mm FROM TERMINAL.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- CENTER TERMINAL LEAD IS OPTIONAL. TERMINAL LEAD IS CONNECTED TO TERMINAL LEAD # 4. 5
- 6. PINS 1, 2, 5 AND 6 ARE TIED TO THE FLAG.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.70	0.80		
A1	0.00	0.05		
A3	0.20	REF		
b	0.25	0.35		
b1	0.51	0.61		
D	2.00 BSC			
D2	1.00	1.20		
E	2.00	) BSC		
E2	1.10	1.30		
е	0.65	5 BSC		
K	0.15	REF		
L	0.20	0.30		
L2	0.20 0.30			
J	0.27 REF			
J1	0.65	REF		

#### SOLDERMASK DEFINED **MOUNTING FOOTPRINT**



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